

Search Notes

Application/Control No.

10/520,774

Examiner

Linh T. Nguyen

Applicant(s)/Patent under
Reexamination

MARUYAMA ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Key words searched on East.	4/5/2006	LN